Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/568,184	SUKEGAWA ET AL.	
Examiner	Art Unit	
HIEU T. VO	3747	

SEARCHED				
Class	Subclass	Date	Examiner	
123	406.55 406.45 301 305 299	9/29/2007	VH	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOT (INCLUDING SEARCH	STRATEGY)
	DATE	EXMR
EAST	9/29/2007	VH.
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